# N-Channel Power MOSFET 100 V, 17 A, 81 m $\Omega$

#### Features

- Low R<sub>DS(on)</sub>
- High Current Capability
- 100% Avalanche Tested
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

## **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

	· -			,	
Para	meter		Symbol	Value	Unit
Drain-to-Source Voltage		V <sub>DSS</sub>	100	V	
Gate-to-Source Voltage - Continuous			V <sub>GS</sub>	±20	V
Continuous Drain	Steady	$T_{C} = 25^{\circ}C$	Ι <sub>D</sub>	17	А
Current	State	$T_{\rm C} = 100^{\circ}{\rm C}$		11	
Power Dissipation	Steady State	T <sub>C</sub> = 25°C	P <sub>D</sub>	71	W
Pulsed Drain Current	tp	= 10 μs	I <sub>DM</sub>	62	А
Operating and Storage	Temperat	ture Range	T <sub>J</sub> , T <sub>stg</sub>	–55 to +175	°C
Source Current (Body Diode)			۱ <sub>S</sub>	17	А
Single Pulse Drain-to-Source Avalanche Energy (V <sub>DD</sub> = 50 Vdc, V <sub>GS</sub> = 10 Vdc, $I_{L(pk)} = 17 \text{ A}, L = 0.3 \text{ mH}, R_G = 25 \Omega$ )			E <sub>AS</sub>	43	mJ
Lead Temperature for S Purposes, 1/8" from Ca		Seconds	ΤL	260	°C

#### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Case (Drain) Steady State	$R_{\theta JC}$	2.1	°C/W
Junction-to-Ambient (Note 1)	$R_{\theta JA}$	40	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surface mounted on FR4 board using 1 sq in pad size,

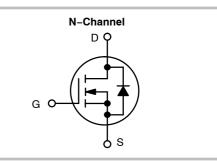
(Cu Area 1.127 sq in [2 oz] including traces).

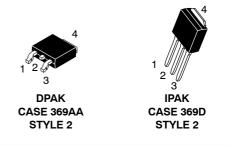


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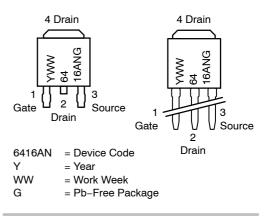
#### http://onsemi.com

V <sub>(BR)DSS</sub> R <sub>DS(on)</sub> MAX		I <sub>D</sub> MAX (Note 1)
100 V	81 mΩ @ 10 V	17 A





MARKING DIAGRAM & PIN ASSIGNMENTS



## ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

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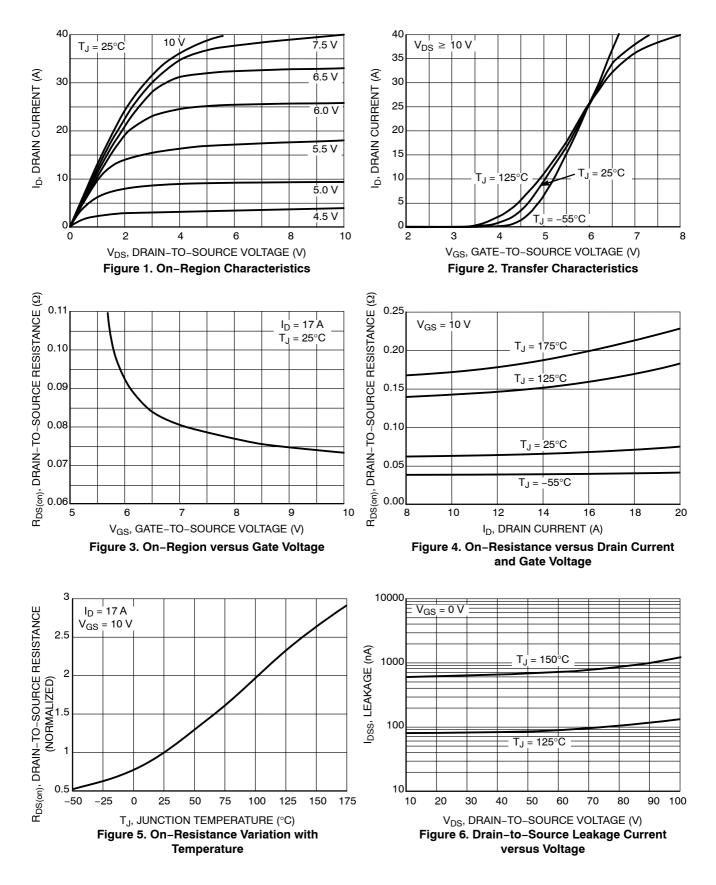
Semiconductor Components Industries, LLC, 2009 November, 2009 – Rev. 0

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}C$ unless otherwise noted)

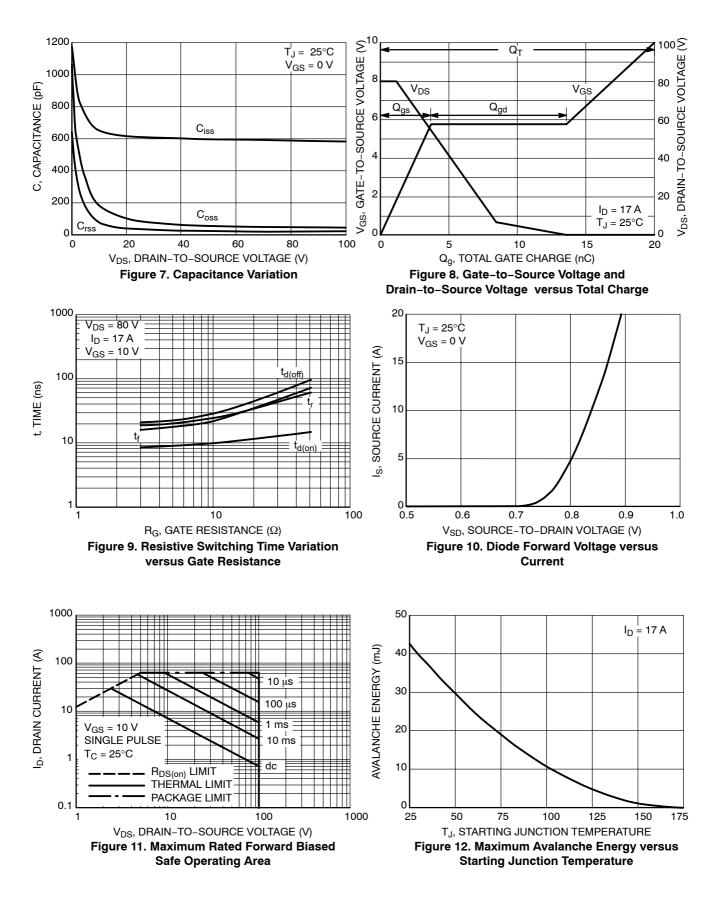
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•				•	•	•
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, $I_D$ = 250 $\mu A$		100			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				112		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C			1.0	μA
		$V_{DS} = 100 V$	T <sub>J</sub> = 125°C			100	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> =	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D =$	250 μΑ	2.0		4.0	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				7.7		mV/°C
Drain-to-Source On-Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub>	= 17 A		73	81	mΩ
Forward Transconductance	gFS	V <sub>DS</sub> = 5 V, I <sub>D</sub> =	= 10 A		12		S
CHARGES, CAPACITANCES AND GA	TE RESISTAN	CE					
Input Capacitance	C <sub>ISS</sub>				620		pF
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MH	z, V <sub>DS</sub> = 25 V		110		1
Reverse Transfer Capacitance	C <sub>RSS</sub>				50		
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 80 V, $I_{D}$ = 17 A			20		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				1.0		
Gate-to-Source Charge	Q <sub>GS</sub>				3.6		
Gate-to-Drain Charge	Q <sub>GD</sub>				10		
Plateau Voltage	V <sub>GP</sub>				5.8		V
Gate Resistance	R <sub>G</sub>				2.4		Ω
SWITCHING CHARACTERISTICS (Not	e 4)				•	•	
Turn-On Delay Time	t <sub>d(on)</sub>				9.2		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 V, V <sub>DD</sub>	a = 80 V.		22		
Turn-Off Delay Time	t <sub>d(off)</sub>	I <sub>D</sub> = 17 A, R <sub>G</sub> =	6.1 Ω΄		24		
Fall Time	t <sub>f</sub>	l F			20		
DRAIN-SOURCE DIODE CHARACTER	RISTICS				•	•	
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 17 A	T <sub>J</sub> = 25°C T <sub>.1</sub> = 125°C		0.85 0.7	1.2	V
Reverse Recovery Time	t <sub>rr</sub>	1 <sub>J</sub> = 125°C			56		ns
-		V <sub>GS</sub> = 0 V, dI <sub>S</sub> /dt = 100 A/µs, I <sub>S</sub> = 17 A			- 56 - 41		115
Charge Time	t <sub>a</sub> ⁺						-
Discharge Time	t <sub>b</sub>				15		
Reverse Recovery Charge	Q <sub>RR</sub>				135		nC

Surface mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).
Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
Switching characteristics are independent of operating junction temperatures.

## **TYPICAL CHARACTERISTICS**



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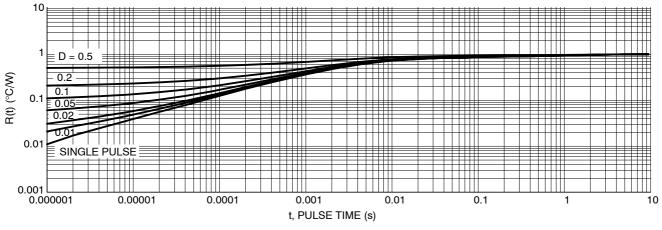


Figure 13. Thermal Response

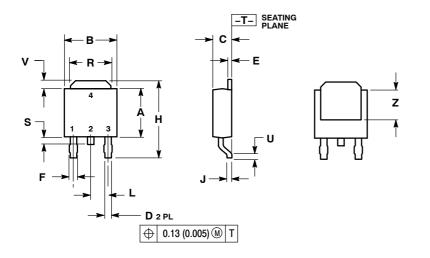
#### **ORDERING INFORMATION**

Device	Package	Shipping†
NTD6416ANT4G	DPAK (Pb-Free)	2500 / Tape & Reel
NTD6416AN-1G	IPAK (Pb-Free)	75 Units / Rail

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

## PACKAGE DIMENSIONS

DPAK CASE 369AA-01 ISSUE A

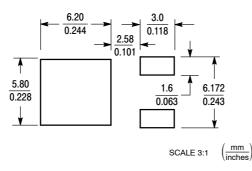


NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.235	0.245	5.97	6.22	
в	0.250	0.265	6.35	6.73	
С	0.086	0.094	2.19	2.38	
D	0.025	0.035	0.63	0.89	
Е	0.018	0.024	0.46	0.61	
F	0.030	0.045	0.77	1.14	
н	0.386	0.410	9.80	10.40	
J	0.018	0.023	0.46	0.58	
L	0.090 BSC		2.29 BSC		
R	0.180	0.215	4.57	5.45	
S	0.024	0.040	0.60	1.01	
U	0.020		0.51		
V	0.035	0.050	0.89	1.27	
z	0.155		3.93		

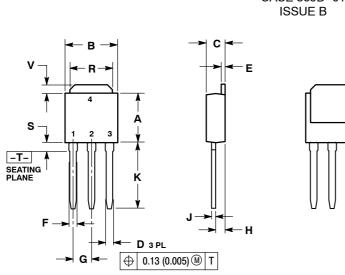
STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

**SOLDERING FOOTPRINT\*** 



\*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### PACKAGE DIMENSIONS



DPAK CASE 369D-01

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#### NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982 2

CONTROLLING DI	MENSION: INCH.
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	INC	HES	MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.235	0.245	5.97	6.35	
в	0.250	0.265	6.35	6.73	
С	0.086	0.094	2.19	2.38	
D	0.027	0.035	0.69	0.88	
Е	0.018	0.023	0.46	0.58	
F	0.037	0.045	0.94	1.14	
G	0.090	) BSC	2.29 BSC		
н	0.034	0.040	0.87	1.01	
J	0.018	0.023	0.46	0.58	
κ	0.350	0.380	8.89	9.65	
R	0.180	0.215	4.45	5.45	
S	0.025	0.040	0.63	1.01	
V	0.035	0.050	0.89	1.27	
z	0.155		3.93		

STYLE 2: PIN 1. GATE 2. DRAIN З. SOURCE 4 DRAIN

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